Applicant(s)/Patent Under Application/Control No. Reexamination 10/551,436 AVNI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2621 Nhon T. Diep **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY Α US-6,314,211 11-2001 Kim et al. 382/285 US-7,057,664 06-2006 В Law et al. 348/448 US-С US-D US-Ε US-F US-G US-Н US-US-US-Κ L US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

W

Х